

ZXTN19020DFF 20V, SOT23F, NPN high gain power transistor

Summary

 $BV_{CEX} > 70V \\ BV_{CEO} > 20V \\ BV_{ECO} > 4.5V \\ I_{C(cont)} = 6.5A \\ V_{CE(sat)} = < 30mV @ 1A \\ R_{CE(sat)} = 18m\Omega \\ P_{D} = 1.5W$





С

Complementary part number ZXTP19020DFF

Description

Advanced process capability has been used to maximize the performance of this transistor. The SOT23F package is compatible with the industry standard SOT23 footprint but offers lower profile and higher dissipation for applications where power density is of utmost importance.

Features

- Very low saturation voltage
- High gain
- High forward blocking voltage
- · Low profile high dissipation package

Applications

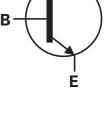
- MOSFET and IGBT gate driving
- LED driving
- Strobe flash
- Motor drive
- Micro buffers

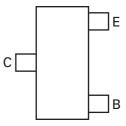
Ordering information

Device	Reel size	Tape width	Quantity
	(inches)	(mm)	per reel
ZXTN19020DFFTA	7	8	3000

Device marking

1E3





Pinout - top view

Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Collector-base voltage	V _{CBO}	70	V
Collector-emitter voltage (forward blocking)	V _{CEX}	70	V
Collector-emitter voltage (base open)	V _{CEO}	20	V
Emitter-collector voltage (reverse blocking)	V _{ECO}	4.5	V
Emitter-base voltage	V _{EBO}	7	V
Continuous collector current ^(c)	Ι _C	6.5	А
Base current	Ι _Β	1	А
Peak pulse current	I _{CM}	20	А
Power dissipation at $T_{amb} = 25^{\circ}C^{(a)}$	P _D	0.84	W
Linear derating factor		6.72	mW/°C
Power dissipation at $T_{amb} = 25^{\circ}C^{(b)}$	PD	1.34	W
Linear derating factor		10.72	mW/°C
Power dissipation at $T_{amb} = 25^{\circ}C^{(c)}$	P _D	1.5	W
Linear derating factor		12.0	mW/°C
Power dissipation at $T_{amb} = 25^{\circ}C^{(d)}$	P _D	2.0	W
Linear derating factor		16.0	mW/°C
Operating and storage temperature range	T _j , T _{stg}	- 55 to 150	°C

Thermal resistance

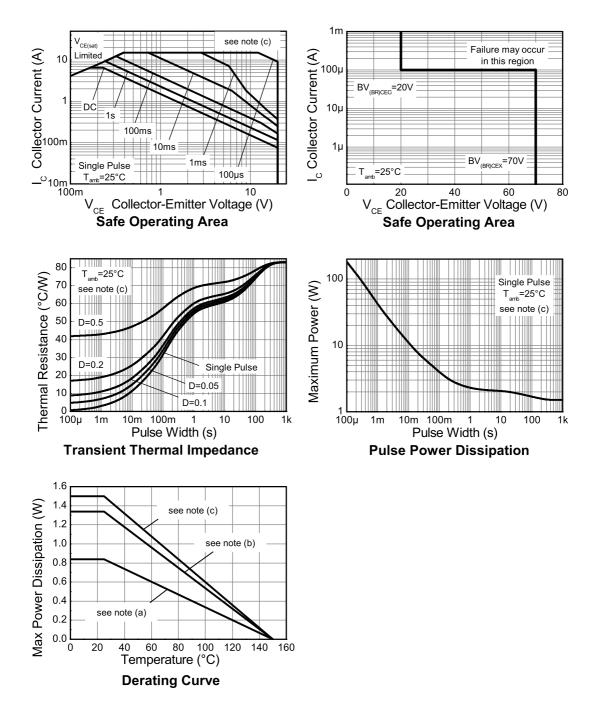
Parameter	Symbol	Value	Unit
Junction to ambient ^(a)	$R_{\Theta JA}$	149.3	°C/W
Junction to ambient ^(b)	$R_{\Theta JA}$	93.4	°C/W
Junction to ambient ^(c)	$R_{\Theta JA}$	83.3	°C/W
Junction to ambient ^(d)	$R_{\Theta JA}$	60	°C/W

NOTES:

(a) For a device surface mounted on 15mm x 15mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

(b) Mounted on 25mm x 25mm x 1.6mm FR4 PCB with a high coverage of single sided 2 oz copper in still air conditions. (c) Mounted on 50mm x 50mm x 1.6mm FR4 PCB with a high coverage of single sided 2 oz copper in still air conditions. (d) As (c) above measured at t<5secs.

Characteristics



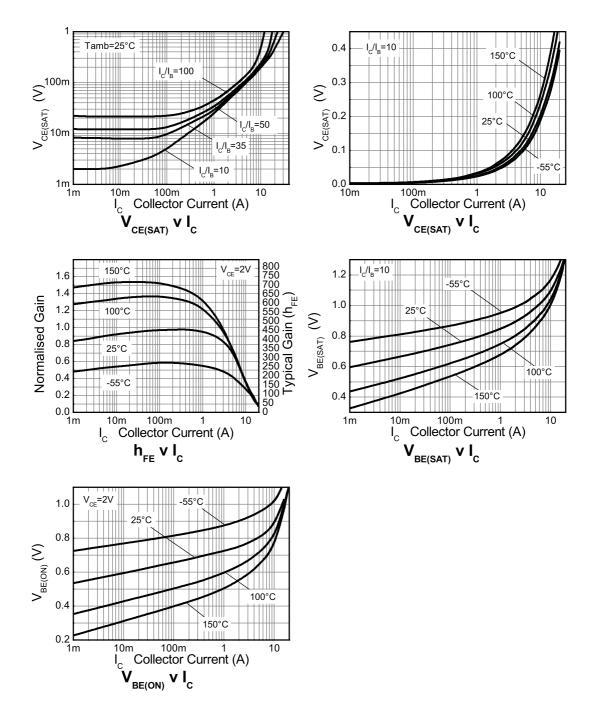
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-base breakdown voltage	BV _{CBO}	70	100		V	I _C = 100μA
Collector-emitter breakdown voltage (forward blocking)	BV _{CEX}	70	100		V	$\label{eq:loss} \begin{split} I_C &= 100 \mu A, R_{BE} \leq 1 k \Omega \text{ or} \\ -1V < V_{BE} < 0.25V \end{split}$
Collector-emitter breakdown voltage (base open)	BV _{CEO}	20	30		V	I _C = 10mA ^(*)
Emitter-base breakdown voltage	BV _{EBO}	7	8.4		V	I _E = 100μA
Emitter-collector breakdown voltage (reverse blocking)	BV _{ECX}	6	8.4		V	$\label{eq:less_eq} \begin{split} I_{E} &= 100 \mu A, R_{BC} \leq 1 k \Omega \text{ or} \\ 0.25 V > V_{BC} > -0.25 V \end{split}$
Emitter-collector breakdown voltage (base open)	BV _{ECO}	4.5	5.7		V	I _E = 100μA,
Collector-base cut-off current	I _{CBO}		<1	50 20	nA μA	$V_{CB} = 56V$ $V_{CB} = 56V$, $T_{amb} = 100^{\circ}C$
Collector-emitter cut-off current	I _{CEX}		-	100	nA	$V_{CE} = 56V, R_{BE} \le 1k\Omega \text{ or} \\ -1V < V_{BE} < 0.25V$
Emitter-base cut-off current	I _{EBO}		<1	50	nA	V _{EB} = 5.6V
Collector-emitter saturation	$V_{CE(sat)}$		25	30	mV	$I_{C} = 1A, I_{B} = 100 \text{mA}^{(*)}$
voltage			45	65	mV	$I_{C} = 1A, I_{B} = 10mA^{(*)}$
			70	95	mV	I _C = 2A, I _B = 20mA ^(*)
			55	75	mV	I _C = 2A, I _B = 40mA ^(*)
			140	190	mV	I _C = 6.5A, I _B = 180mA ^(*)
Base-emitter saturation voltage	V _{BE(sat)}		940	1050	mV	I _C = 6.5A, I _B = 180mA ^(*)
Base-emitter turn-on voltage	V _{BE(on)}		830	950	mV	$I_{C} = 6.5A, V_{CE} = 2V^{(*)}$
Static forward current transfer	h _{FE}	300	450	900		$I_{C} = 0.1A, V_{CE} = 2V^{(*)}$
ratio		260	420			$I_{C} = 2A, V_{CE} = 2V^{(*)}$
		160	270			$I_{C} = 6.5A, V_{CE} = 2V^{(*)}$
		50	80			$I_{C} = 15A, V_{CE} = 2V^{(*)}$
Transition frequency	f _T		160		MHz	I _C = 50mA, V _{CE} = 10V f = 50MHz
Input capacitance	C _{ibo}		297		pF	V _{EB} = 0.5V, f = 1MHz ^(*)
Output capacitance	C _{obo}		32.6	40	pF	V _{CB} = 10V, f = 1MHz ^(*)
Delay time	t _d		129		ns	V _{CC} = 10V.
Rise time	t _r		96		ns	I _C = 1A,
Storage time	t _s		398		ns	I _{B1} = -I _{B2} = 10mA.
Fall time	t _f		90		ns	

Electrical characteristics (at T_{amb} = 25°C unless otherwise stated)

NOTES:

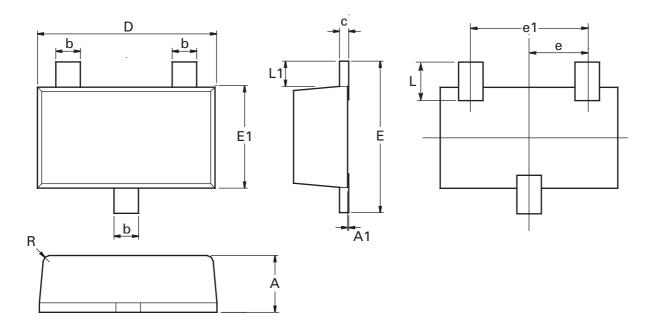
(*) Measured under pulsed conditions. Pulse width \leq 300 μ s; duty cycle \leq 2%.

Typical characteristics



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Package outline - SOT23F



Dim.	Millimeters		Inches		Dim.	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Max.	Max.
A	0.80	1.00	0.0315	0.0394	E	2.30	2.50	0.0906	0.0984
A1	0.00	0.10	0.00	0.0043	E1	1.50	1.70	0.0590	0.0669
b	0.35	0.45	0.0153	0.0161	E2	1.10	1.26	0.0433	0.0496
С	0.10	0.20	0.0043	0.0079	L	0.48	0.68	0.0189	0.0268
D	2.80	3.00	0.1102	0.1181	L1	0.30	0.50	0.0153	0.0161
е	0.95	ref	0.037	74 ref	R	0.05	0.15	0.0019	0.0059
e1	1.80	2.00	0.0709	0.0787	0	0°	12°	0°	12°

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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Zetex sales offices

Europe	Americas	Asia Pacific	Corporate Headquarters
Zetex GmbH Kustermann-park Balanstraße 59 D-81541 München Germany	Zetex Inc 700 Veterans Memorial Highway Hauppauge, NY 11788 USA	Zetex (Asia Ltd) 3701-04 Metroplaza Tower 1 Hing Fong Road, Kwai Fong Hong Kong	Zetex Semiconductors plc Zetex Technology Park, Chadderton Oldham, OL9 9LL United Kingdom
Telefon: (49) 89 45 49 49 0 Fax: (49) 89 45 49 49 49 europe.sales@zetex.com	Telephone: (1) 631 360 2222 Fax: (1) 631 360 8222 usa.sales@zetex.com	Telephone: (852) 26100 611 Fax: (852) 24250 494 asia.sales@zetex.com	Telephone: (44) 161 622 4444 Fax: (44) 161 622 4446 hq@zetex.com

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